

ESD Protection Diode - SiSTVSE33B

Rev 1.0 23/06/25

Bidirectional transient voltage suppressor diode in bare die form

Features:

- Bidirectional configuration
- Low leakage
- Low capacitance
- 3.3V stand-off voltage
- Single bond-wire requirement

Ordering Information

The following part suffixes apply:

- No suffix MIL-STD-750 /2073 Visual Inspection
- "H" MIL-STD-750 /2073 Visual Inspection+ MIL-PRF-38534 Class H LAT
- "K" MIL-STD-750 /2073 Visual Inspection+ MIL-PRF-38534 Class K LAT

LAT = Lot Acceptance Test.

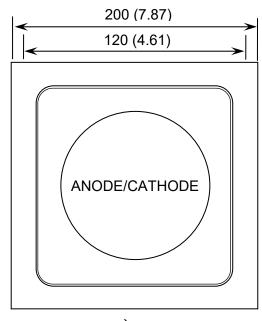
For further information on LAT process flows see below.

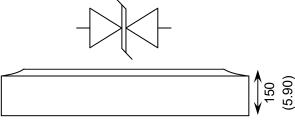
www.siliconsupplies.com\quality\bare-die-lot-qualification

Supply Formats:

- Default Die in Waffle Pack (400 per tray capacity)
- Sawn Wafer on Tape By specific request
- Unsawn Wafer By specific request
- Die Thickness <> 150µm(5.9 Mils) On request
- With additional electrical selection On request

Die Dimensions in µm (mils)





CHIP BACKSIDE IS ANODE/CATHODE

Mechanical Specification

Die Size (Unsawn)	200 x 200 7.87 x 7.87	μm mils	
Anode Pad Size	120 Ø 4.61 Ø	µm mils	
Die Thickness	150 (±15) 5.90 (±0.59)	μm mils	
Top Metal Composition	AlSiCu 4µm		
Back Metal Composition	Ti/Ni/Ag 2µm		





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Absolute Maximum Ratings¹ T_J = 25°C unless otherwise stated

PARAMETER	SYMBOL	VALUE	UNIT
Peak Pulse Power (t _p = 8/20 μs)	P _{PK}	100	W
Operating Junction temperature	T _J	-55 to 150	°C
Storage Temperature Range	T _{STG}	-65 to 150	°C

^{1.} Operation above the absolute maximum rating may cause device failure. Operation at the absolute maximum ratings, for extended periods, may reduce device reliability.

ESD Rating Compliant to IEC 61000-4-2

PARAMETER	SYMBOL	VALUE	UNIT
Air	V _{ESD}	±30	kV
Contact		±30	kV

Electrical Characteristics T_J = 25°C unless otherwise stated

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNIT
Reverse Stand-Off Voltage	V _{RWM}		-	-	±3.3	V
Reverse Breakdown Voltage	V _{BR}	I _T = 1mA	3.3	4.1	5.0	V
Reverse Leakage	I _R	V _{RWM} = 3.3V	1	-	100	nA
Clamping Voltage	V _C ²	$I_{PP} = 1A, t_p = 8/20 \mu s$	-	-	6.5	V
	VC	$I_{PP} = 11A, t_p = 8/20 \mu s$	-	-	10.0	
Junction Capacitance	CJ	$V_R = 0V$, $f = 1MHz$	-	15	20	pF

^{2.} Clamping Voltage was measured by 8/20 μ s current waveform, R_S = 2 Ω , according to IEC61000-4-5

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